

Search Notes

Application/Control No.

10/826,540

Examiner

Chuck Huynh

Applicant(s)/Patent under
Reexamination

SCHREYER ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	9/14/2006	CH
455	404.1	9/14/2006	CH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/ Subclass Search	9/14/2006	CH
Review Used Arts	9/14/2006	CH
Combine Text Search	9/14/2006	CH